Issue	Classification

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,327	LEE ET AL
Examiner	Art Unit

2818

la l	SUE CLASSIFICATION					
ORIGINAL	CROSS REFERENCE	>E(S)				
CLASS SUBCLASS CLASS	SUBCLASS (ONE SUBCLAS	S PER BLOCK)				
257 295 257	298 303 306 324					
INTERNATIONAL CLASSIFICATION 438	3 240					
н о 1 к 29/76						
(Assistant Examiner) :::: (Date)	andy Muy Q_	Total Claims Allowed: 33				
G. Starly 5-34-05 (Legal Instruments Examiner): (Date)	Andy: Huynh: 5/05 (Primary Examiner) (Date)	O.G. O.G. Print Claim(s) Print Fig. 1 6				

Andy Huynh

	laims	renur	enumbered in the same order as presented by applicant							□СРА			☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Finat	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	(1)		24	31			61			91			121			151			181
	2		25	32			62			92			122			152			182
2	3		26	33			63			93			123			153			183
	4		28	34			64			94			124			154			184
3	5		30	33)			65			95			125			155			185_
4	6		31	36			66			96			126			156			186
5	7		32	37			67			97			127			157		<u> </u>	187
	8		33	38			68]		98			128			158			188
6	9			39			69			99			129			159			189
7	10			40			70			100			130			160			190_
8	11			41			71			101			131			161			191
9	12			42			72	1		102			132			162			192
10	13			43			73]		103			133			163			193
11	14			44			74	1		104			134			164			194
12	15			45			75	}		105			135			165			195
16	6			46			76	}		106			136			166			196
13	17			47			77]		107			137			167			197
14	18		_	48			78]		108			138			168			198
15	19			49			79	1		109			139			169			199
17	20		_	50			80	1		110			140			170			200
	21			51			81			111			141			171			201
18	22			52			82	1		112			142			172			202
	. 23			53			83			113			143			173			203
19	24			54			84	1		114			144			174			204
20	25			55			85	1		115			145			175			205
21	26			56			86	1		116			146			176			206
29	00			57	1		87			117)		147			177			207
22	28			58	1		88	1		118)		148			178			208
27	29			59	1		89	1		119			149		-	179			209
23	30			60			90			120			150	L		180			210